# imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



## Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China





September 2000

ТΜ

### FQB3N90 / FQI3N90 900V N-Channel MOSFET

#### **General Description**

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply.

#### **Features**

- + 3.6A, 900V,  $R_{DS(on)}$  = 4.25  $\Omega$  @  $V_{GS}$  = 10 V + Low gate charge ( typical 20 nC)
- Low Crss (typical 8.0 pF) •
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



#### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQB3N90 / FQI3N90	Units
V <sub>DSS</sub>	Drain-Source Voltage		900	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°	C)	3.6	А
	- Continuous (T <sub>C</sub> = 100	°C)	2.28	А
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	14.4	А
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		450	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	3.6	А
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	13	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.0	V/ns
P <sub>D</sub>	Power Dissipation $(T_A = 25^{\circ}C)^*$		3.13	W
	Power Dissipation $(T_C = 25^{\circ}C)$		130	W
	- Derate above 25°C		1.04	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

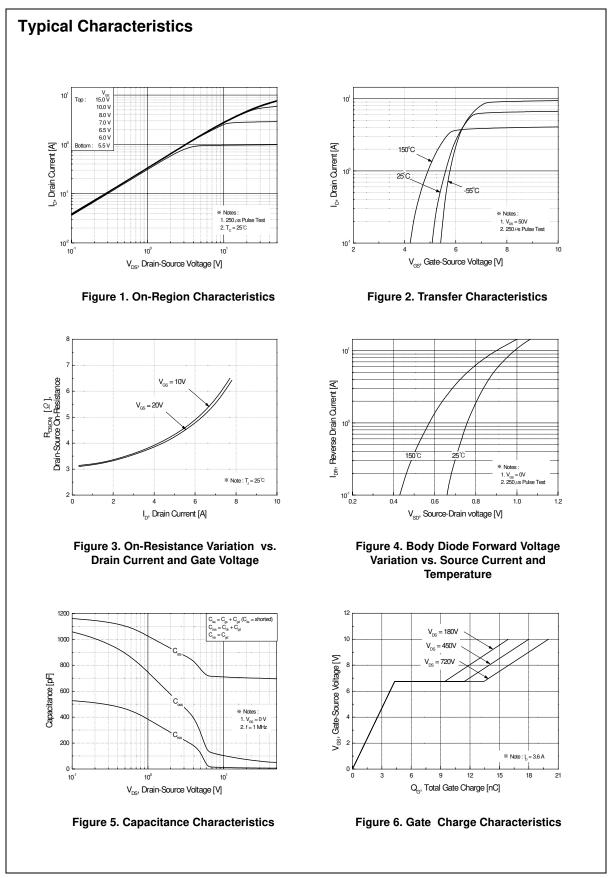
#### **Thermal Characteristics**

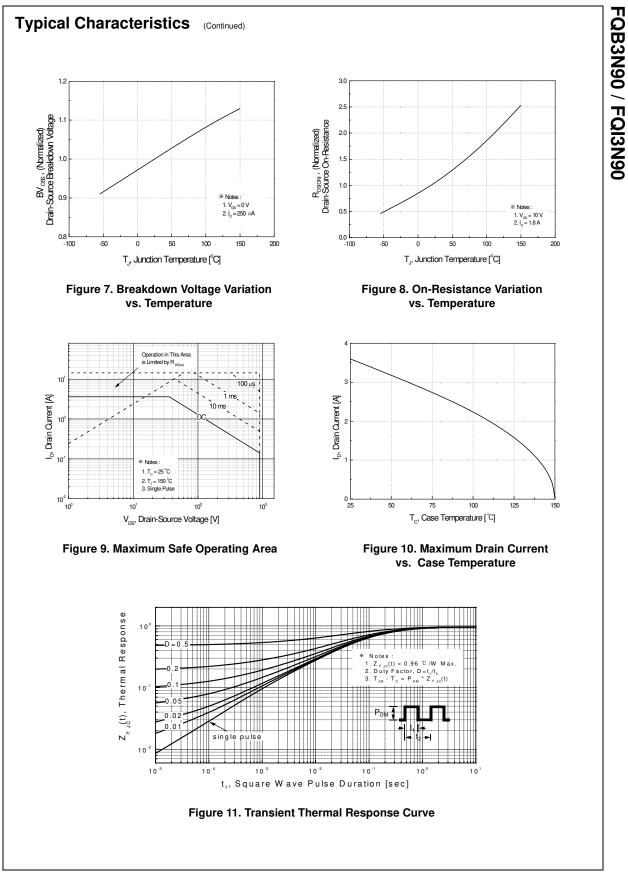
Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.96	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

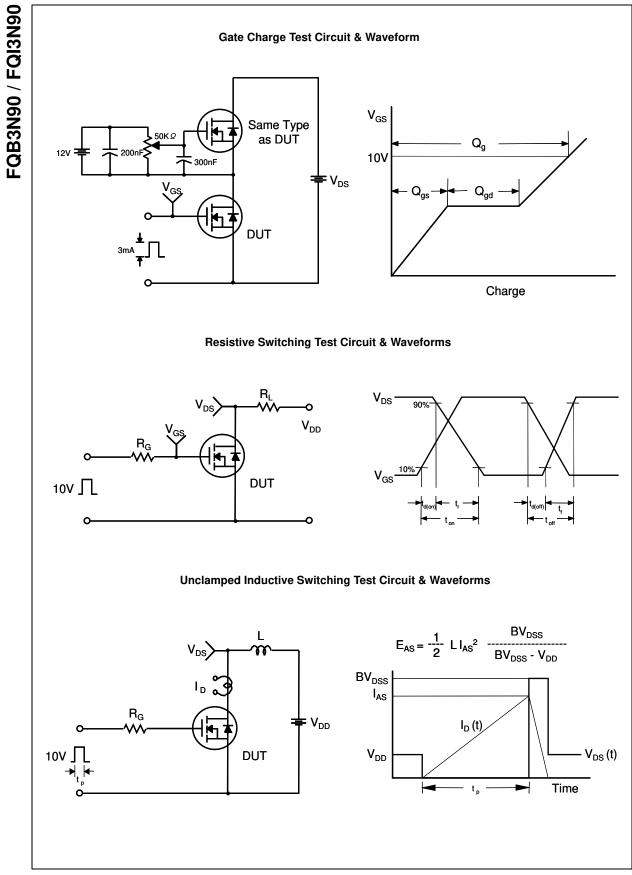
	Parameter	Test Conditions		Min	Тур	Max	Units
Off Cha	aracteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		900			V
ΔBV <sub>DSS</sub> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 2	25°C		1.0		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 900 V, V <sub>GS</sub> = 0 V				10	μA
		V <sub>DS</sub> = 720 V, T <sub>C</sub> = 125°C				100	μA
GSSF	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$				100	nA
GSSR	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$				-100	nA
						1	1
Jn Cna / <sub>GS(th)</sub>	aracteristics Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA		3.0		5.0	V
RDS(on)	Static Drain-Source						
(0)	On-Resistance	$V_{GS} = 10 \text{ V}, I_{D} = 1.8 \text{ A}$			3.3	4.25	Ω
9fs	Forward Transconductance	$V_{DS} = 50 \text{ V}, I_D = 1.8 \text{ A}$ (No	ote 4)		4.1		S
	ic Characteristics	1					
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz			700	910	pF
C <sub>oss</sub>	Output Capacitance				65	85	pF
C <sub>rss</sub>	Reverse Transfer Capacitance				8.0	10	pF
Switch	ing Characteristics						
	Turn-On Delay Time				18	45	ns
d(on)							
	,	$V_{DD} = 450 \text{ V}, \text{ I}_{D} = 3.6 \text{ A},$			45		ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD}$ = 450 V, I <sub>D</sub> = 3.6 A, R <sub>G</sub> = 25 Ω			45 40	100	-
r d(off)	Turn-On Rise Time Turn-Off Delay Time	$R_{G} = 25 \Omega$	e 4, 5)		40	100 90	ns
t <sub>r</sub> td(off) tf	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time	R <sub>G</sub> = 25 Ω (Note	e 4, 5)		40 35	100 90 80	ns ns
t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub>	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	$R_{G} = 25 $ Ω (Note $V_{DS} = 720 $ V, $I_{D} = 3.6 $ A,	e 4, 5)		40 35 20	100 90	ns ns nC
r d(off) f Q <sub>g</sub> Q <sub>gs</sub>	Turn-On Rise Time         Turn-Off Delay Time         Turn-Off Fall Time         Total Gate Charge         Gate-Source Charge	$R_{G} = 25 \Omega$ (Note V <sub>DS</sub> = 720 V, I <sub>D</sub> = 3.6 A, V <sub>GS</sub> = 10 V	e 4, 5)		40 35 20 4.3	100 90 80 26	ns ns nC nC
t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>gs</sub>	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	$R_{G} = 25 \Omega$ (Note V <sub>DS</sub> = 720 V, I <sub>D</sub> = 3.6 A, V <sub>GS</sub> = 10 V			40 35 20	100 90 80 26 	ns ns nC
	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics at	$R_{G} = 25 \ \Omega $ (Note $V_{DS} = 720 \ V, \ I_{D} = 3.6 \ A, \ V_{GS} = 10 \ V $ (Note the formula of the second			40 35 20 4.3	100 90 80 26  	ns ns nC nC
t <sub>r</sub> Qg Qgs Qgd Drain-S	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge <b>Source Diode Characteristics an</b> Maximum Continuous Drain-Source Diode	$R_{G} = 25 \Omega$ (Note $V_{DS} = 720 \text{ V}, I_{D} = 3.6 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note <b>nd Maximum Ratings</b> de Forward Current			40 35 20 4.3	100 90 80 26   3.6	ns ns nC nC nC
r d(off) G Qg Qgs Qgd <b>Drain-S</b> S	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics an Maximum Continuous Drain-Source Diode F	$R_{G} = 25 \Omega$ (Note $V_{DS} = 720 \text{ V}, I_{D} = 3.6 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note <b>nd Maximum Ratings</b> de Forward Current Forward Current		   	40 35 20 4.3 9.1	100 90 80 26  	ns ns nC nC
t <sub>r</sub> t <sub>d(off)</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub> Drain-S	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge <b>Source Diode Characteristics an</b> Maximum Continuous Drain-Source Diode	$R_{G} = 25 \Omega$ (Note $V_{DS} = 720 \text{ V}, I_{D} = 3.6 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note <b>nd Maximum Ratings</b> ide Forward Current Forward Current $V_{GS} = 0 \text{ V}, I_{S} = 3.6 \text{ A}$		    	40 35 20 4.3 9.1	100 90 80 26   3.6	ns ns nC nC nC
tr d(off) tf Qg Qgs Qgd <b>Drain-S</b>	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics an Maximum Continuous Drain-Source Diode F	$R_{G} = 25 \Omega$ (Note $V_{DS} = 720 \text{ V}, I_{D} = 3.6 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note <b>nd Maximum Ratings</b> de Forward Current forward Current $V_{GS} = 0 \text{ V}, I_{S} = 3.6 \text{ A},$ $V_{GS} = 0 \text{ V}, I_{S} = 3.6 \text{ A},$		    	40 35 20 4.3 9.1	100 90 80 26   3.6 14.4	ns ns nC nC nC A A

FQB3N90 / FQI3N90



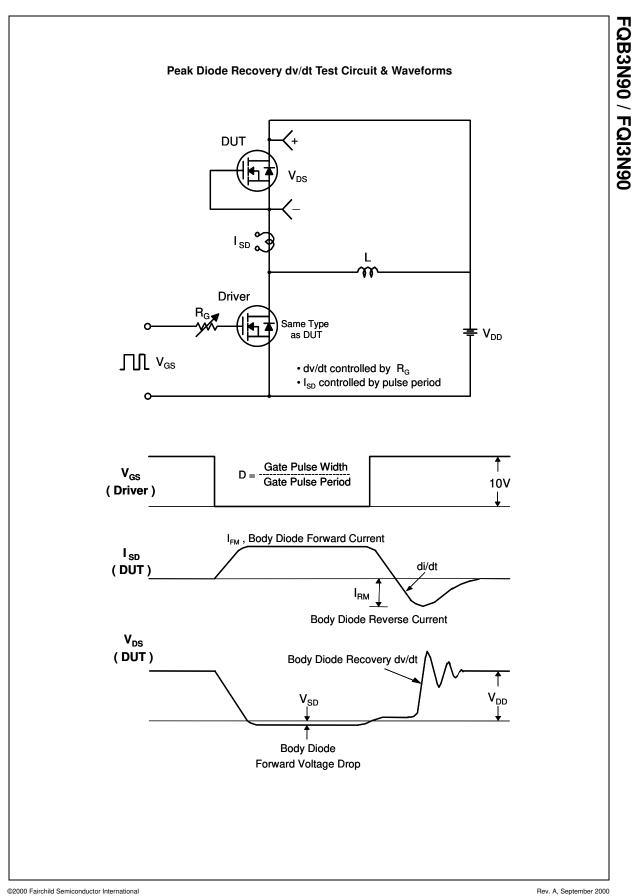




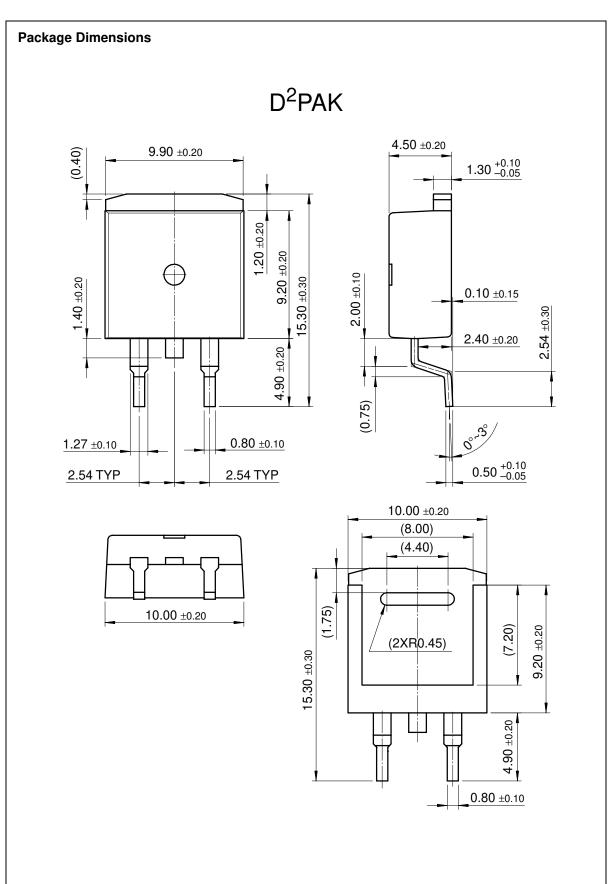


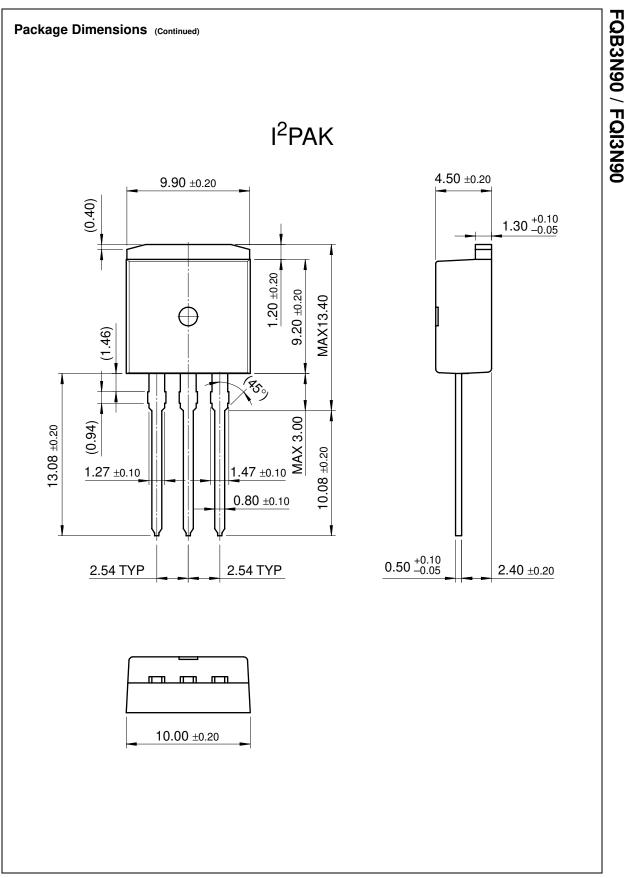
©2000 Fairchild Semiconductor International

Rev. A, September 2000



FQB3N90 / FQI3N90





#### TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACEx <sup>™</sup>	FASTr <sup>™</sup>	QFET™	VCX™
Bottomless <sup>™</sup>	GlobalOptoisolator <sup>™</sup>	QS™	
CoolFET <sup>™</sup>	GTO <sup>™</sup>	QT Optoelectronics™	
CROSSVOLT <sup>™</sup>	HiSeC <sup>™</sup>	Quiet Series™	
DOME <sup>™</sup>	ISOPLANAR <sup>™</sup>	SuperSOT™-3	
E <sup>2</sup> CMOS <sup>™</sup>	MICROWIRE <sup>™</sup>	SuperSOT™-6	
EnSigna <sup>™</sup>	OPTOLOGIC <sup>™</sup>	SuperSOT™-8	
FACT <sup>™</sup>	OPTOPLANAR <sup>™</sup>	SyncFET™	
FACT Quiet Series <sup>™</sup>	POP <sup>™</sup>	TinyLogic™	
FACT Quiet Series™	POP™	TinyLogic™	
FAST <sup>®</sup>	PowerTrench <sup>®</sup>	UHC™	

#### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

#### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR INTERNATIONAL.

#### As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### **PRODUCT STATUS DEFINITIONS**

#### **Definition of Terms**

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.